

n-channel JFETs designed for . . .

- VHF Amplifiers
- Front End High Sensitivity Amplifiers
- Oscillators
- Mixers

Performance Curves NZA
See Section 4

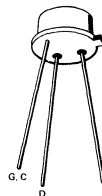
BENEFITS

- Industry Standard
- High Power Gain
16 dB at 105 MHz, Common-Gate
11 dB at 450 MHz, Common-Gate
- Low Noise
2.7 dB Noise Figure at 450 MHz
- Wide Dynamic Range
Greater than 100 dB
- 75 Ω Input Match Common Gate

ABSOLUTE MAXIMUM RATINGS (25°C)

Gate-Drain or Gate-Source Voltage	-25 V
Gate Current	20 mA
Total Power Dissipation at $T_A = 25^\circ\text{C}$	500 mW
Power Derating to 150°C	4.0 mW/ $^\circ\text{C}$
Storage Temperature Range	-65 to $+150^\circ\text{C}$
Lead Temperature (1/16" from case for 10 seconds)	300°C

TO-52
See Section 5



ELECTRICAL CHARACTERISTICS (25°C unless otherwise noted)

Characteristic		U308			U309			U310			Unit	Test Conditions	
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max			
1	S T A T I C	IGSS		Gate Reverse Current			-150		-150		-150	pA	$V_{GS} = -15\text{ V}$, $V_{DS} = 0$
2							-150		-150		-150	nA	$T_A = 125^\circ\text{C}$
3		BVGSS		Gate-Source Breakdown Voltage		-25		-25		-25		V	$I_G = -1\text{ }\mu\text{A}$, $V_{DS} = 0$
4	D Y N A M I C	VGS(off)		Gate-Source Cutoff Voltage		-1.0	-6.0	-1.0	-4.0	-2.5	-6.0		$V_{DS} = 10\text{ V}$, $I_D = 1\text{ nA}$
5		IDSS		Saturation Drain Current (Note 1)		12		60	12	30	24	60	mA
6		VGS(f)		Gate-Source Forward Voltage			1.0		1.0		1.0		V
7	H I F R E Q	gfg		Common-Gate Forward Transconductance (Note 1)		10		20	10	20	10	18	mmho
8		gog		Common-Gate Output Conductance			150		150		150		μmho
9		Cgd		Drain-Gate Capacitance			2.5		2.5		2.5		pF
10	N F	Cgs		Gate-Source Capacitance			5.0		5.0		5.0		pF
11		en		Equivalent Short Circuit Input Noise Voltage			10		10		10		$\frac{\text{nV}}{\sqrt{\text{Hz}}}$
12		gfg		Common-Gate Forward Transconductance			15		15		15		mmho
13	N F	gog		Common-Gate Output Conductance			0.18		0.18		0.18		mmho
14		Gpg		Common-Gate Power Gain (Note 2)		14	16	14	16	14	16		dB
15		NF		Noise Figure			1.5	2.0	1.5	2.0	1.5	2.0	dB
16							2.7	3.5	2.7	3.5	2.7	3.5	dB

NOTES:

1. Pulse test duration = 2 ms.
2. Gain (G_{pg}) measured at optimum input noise match.

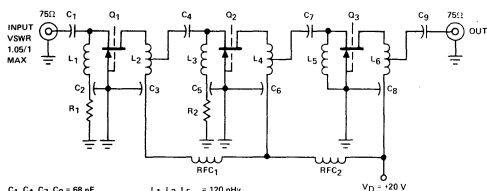
NZA

U308 U309 U310

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APPLICATIONS

200-250 MHz Wideband Amplifier (1 dB Ripple) 3-Stage Amplifier Circuit

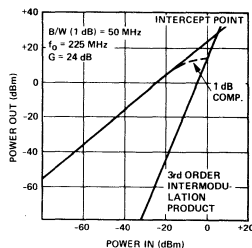


$C_1, C_4, C_7, C_8 = 68 \text{ pF}$
 $C_2, C_5 = 500 \text{ pF}$
 $C_3, C_6, C_9 = 1,000 \text{ pF}$
 $Q_1, Q_2, Q_3 = \text{Siliconix U310}$

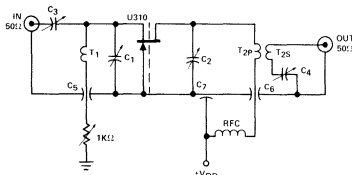
$L_1, L_3, L_5 = 120 \text{ nH}$
 $L_2, L_4, L_6 = 222 \text{ nH}$
 $RFC_1, RFC_2 = 2.2 \text{ }\mu\text{H}$
 $R_1, R_2 = 51 \text{ }\Omega$

$V_{DD} = +20 \text{ V}$

2 Tone Intercept & Compression Point Measurement



450 MHz Common Gate Amplifier

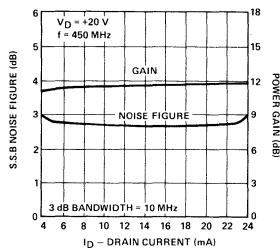


$C_1, C_2 = 0.8 - 1.0 \text{ }\mu\text{F JFD model MVM 010W}$
 $C_3, C_4 = 8 - 35 \text{ pF Ene series 538 002D}$
 $C_5, C_6 = 5000 \text{ pF Ene (2443 000)}$
 $C_7 = 1000 \text{ pF ALLEN-BRADLEY type FASC}$

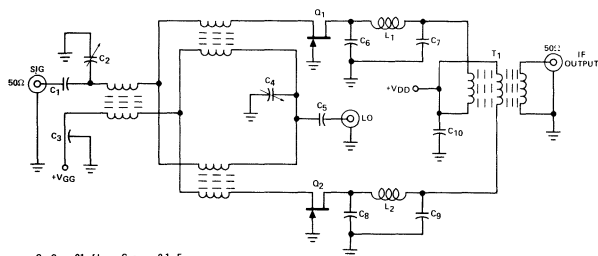
$RFC = 33 \text{ }\mu\text{H MILLER type (9230-30)}$
 $T_1 = \text{one turn, } 16 \text{ copper wire, } \frac{1}{16} \text{ I.D. (Air Core)}$
 $T_2 = \text{one turn, } 16 \text{ copper wire, } \frac{1}{16} \text{ I.D. (Air Core)}$
 $T_3 = \text{one turn, } 16 \text{ copper wire, } \frac{1}{16} \text{ I.D. (Air Core)}$

$V_{DD} = +20 \text{ V}$

Noise Figure vs. Power Gain



Prototype Active Balanced Mixer*

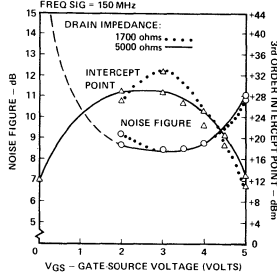


$C_1, C_5 = 0.1 \text{ }\mu\text{F}$
 $C_2, C_4 = 1 - 10 \text{ }\mu\text{F}$
 $C_3 = 1000 \text{ pF}$
 $C_6, C_8 = 30 \text{ pF}$
 $C_7, C_9 = 68 \text{ pF}$

$C_{10} = 0.1 \text{ }\mu\text{F}$
 $L_1, L_2 = 1.3 \text{ }\mu\text{H}$
 $Q_1, Q_2 = \text{U310}$
 $T_1 = \text{RELCOM BT 9}$

Comparison of Mixer IM Characteristics

SOURCE INJECTED MIXER (L.O. & SIGNAL)
 FREQ LO = 120 MHz; POWER LO: +17 dBm
 FREQ SIG = 150 MHz



*Reference Siliconix Application Note AN71-2.